

# SKY63104/SKY63105/SKY63106 12-Output, Any-Frequency, Any-Output Jitter Attenuators/Clock Multipliers with Ultra-Low Jitter

SKY63104/05/06 Jitter Attenuators combine 5th-generation DSPLL® and MultiSynth™ technologies with an ultra-low jitter VCO to deliver ultra-low jitter (<55 fs) for high-performance applications like 112G and 224G SerDes and Coherent Optics. They are designed for applications demanding the highest levels of integration and jitter performance. All PLL components are integrated on-chip, eliminating the risk of noise coupling associated with discrete solutions. The SKY63104 has a single DSPLL with two MultiSynths; the SKY63105 has two DSPLLs with one MultiSynth, and the SKY63106 has three DSPLLs.

All devices support free-run, synchronous, and holdover modes as well as enhanced hitless switching minimizing the phase transients associated when switching between input clocks. These devices are available with either non-volatile memory (NVM), to enable powering up with a known frequency configuration, or with an external flash option.

Programming the SKY63104/05/06 is easy with Skyworks' ClockBuilder® Pro (CBPro) software. The devices can be factory programmed allowing them to power up to known frequencies and settings or shipped as "blank" devices to give more flexibility.

For more information, visit the Skyworks Sales Information page.

# **Applications**

- 56G/112G/224G PAM4 SerDes clocking
- OTN muxponders and transponders
- 100/200/400/600/800G networking line cards
- Synchronous Ethernet
- Datacenter Switches
- Medical imaging
- Test and measurement
- 100G/200G/400G Optical Transceivers

# **Features**

- Utilizes 5th-generation DSPLL and MultiSynth technologies
- ANY input to ANY combination of output frequencies up to 3.2 GHz
- Ultra-low phase jitter (<55 fs typ)
- Enhanced hitless switching minimizes output phase transients (35 ps typ)
- Up to six differential/single-ended Inputs
- Input frequency range
  - Differential: 8 kHz to 1000 MHz
  - LVCMOS: 8 kHz to 250 MHz
- 12 Outputs
- Output frequency range
  - Differential: 8 kHz to 3.2 GHz
  - LVCMOS: 8 kHz to 250 MHz
- Fixed or user-adjustable output formats
- External flash or internal NVM-grade option
- PCIe Gen 1/2/3/4/5/6 compliant
- Simplified API interface
- Full suite of status monitors
- SKY63104: 1 DSPLL, 2 MultiSynth
- SKY63105: 2 DSPLL, 1 MultiSynth
- SKY63106: 3 DSPLL, 0 MultiSynth
- 56-QFN, 8 x 8 mm
- ClockBuilder Pro Configuration Software
- For RoHS and other product compliance information, see the Skyworks Certificate of Conformance.



Figure 1. SKY63104 Simplified Block Diagram (1 x DSPLL + 2 x MultiSynth)





# **1. Features List**

- Generates any output frequency in any format from any input frequency
- Independent XTAL or XO reference inputs eliminate termination resistors
- Ultra-low INTEGER mode jitter performance (DSPLLP+Q):
   <55 fs RMS typ</li>
- DSPLLA (SKY63105/06 only), DSPLLB (SKY63106 only)
  - Independent synchronization DSPLLs
  - 100 fs RMS typ
- Programmable loop bandwidth: 20 Hz to 4 kHz
- Locks to gapped clock inputs
- Hitless input clock switching: automatic or manual with 35 ps typ phase transient
- Four Differential or six Differential/Single-ended clock inputs:
  - Differential: 8 kHz to 1 GHz
  - CMOS: 8 kHz to 250 MHz
  - Up to 12 differential clock outputs:
    - Integer Q dividers: 8 kHz to 3.2 GHz
    - Fractional divider: 8 kHz to 650 MHz
- Up to 24 single-ended clock outputs
- CMOS: 8 kHz to 250 MHz (Integer and Fractional)
- User-programmable alarm thresholds
- Highly configurable outputs:
  - Fixed formats LVDS, S-LVDS, LVPECL, LVCMOS, CML, and HCSL
  - User-programmable signal amplitude
  - Configurable GPIO pins
  - PCIe spread spectrum support
- Output-output skew: ±50 ps
- Utilizes 5th-generation DSPLL and MultiSynth technologies
- Automatic Free-run, Holdover, and Locked modes
- Zero Delay Mode (ZDM) for all PLLs
- Status monitoring (LOS, OOF, PHMON, FLOL and PLOL)
- Core voltage: 3.3 V, 1.8 V
- Output supply pins: 3.3 V, 2.5 V, 1.8 V
- Serial Interface: I<sup>2</sup>C or SPI (3- or 4-wire)
- ClockBuilder Pro software tool simplifies device configuration
- External flash support
- Package: 56-Lead QFN, 8 x 8 mm
- Extended temperature range:
  - -40 to +95 °C ambient
  - –40 to +105 °C board
- Pb-free, RoHS compliant

# 2. Pin Descriptions





Pin Name	Pin Number	Pin Type <sup>1</sup>	Function			
Inputs						
XO_IN	45	1	Input for low phase noise (XO)			
XGND	46	I	XTAL Shield Connect this pin directly to the XTAL and capacitor ground pins. Do not ground the XV pin. XV should be isolated from the PCB ground plane. Refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for layout guidelines.			
ХА	47	1	Crystal Input Input pins for external crystal (XTAL). XA and XB pins can be left unconnected when not			
ХВ	48	I	in use.			

#### Table 1. Pin Descriptions

### Table 1. Pin Descriptions (Continued)

Pin Name	Pin Number	Pin Type <sup>1</sup>	Function				
INO	49						
INOb	50						
IN1	51		Clock Inputs				
IN1b	52	1	INO–IN3 accept an input clock for synchronizing the device. They support both differential and single-ended clock signals. When operating in single-ended mode,				
IN2	53		inputs IN2 and IN3 can provide two SE inputs each for a total of six inputs. Refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for input termination options. These pins are high-impedance and must be terminated externally.				
IN2b	54		INO–IN3 can be disabled in CBPro and the pins left unconnected if unused.				
IN3	55		נאו שמושט כאו שמושט ווו כאירס מהם נהפ pins left unconnected if unused.				
IN3b	56						
Outputs	l	l					
OUT0b	2		Output Clocks				
OUT0	3		The output clocks can be programmed as single-ended CMOS or differential LVDS, S- LVDS, CML, HCSL or ac-coupled LVPECL and support a programmable signal amplitude				
OUT1b	5	0	and common-mode voltage. Desired output signal format is configurable in CBPro. Termination recommendations are provided in the "Fifth Generation DSPLL® Wireline				
OUT1	6		Jitter Attenuator Reference Manual". Unused outputs should be left unconnected.				
OUT2b/GPIO	7		Output Clocks with General-Purpose Input or Output Option				
OUT2/GPIO	8	l or O	Output 2 can alternatively be assigned as two General Purpose Inputs or Outputs (GPIO0, GPIO1) that can be programmed to have any of the input or output control functions listed in "5.10. GPIO (General Purpose Input/Output)/Four-Wire SPI Inter on page 37. Regardless of whether Output 2 is functioning as a clock output or GPIO power supply will be VDDO1.				
OUT3b	9						
OUT3	10						
OUT4b	12						
OUT4	13						
OUT5b	20						
OUT5	21						
OUT6b	22		Output Clocks				
OUT6	23		The output clocks can be programmed as single-ended CMOS or differential LVDS, S-LVDS, CML, HCSL or ac-coupled LVPECL and support a programmable signal amplitude				
OUT7b	25	0	and common-mode voltage. The desired output signal format is configurable in CBPro. Termination recommendations are provided in the "Fifth Generation DSPLL® Wireline				
OUT7	26	1	Jitter Attenuator Reference Manual". Unused outputs should be left unconnected.				
OUT8b	27	1					
OUT8	28	1					
OUT9b	29						
OUT9	30						
OUT10b	32						
OUT10	33	1					
OUT11b/GPIO	34		Output Clocks with General-Purpose Input or Output Option				
OUT11/GPIO	35	l or O	Output 11 can alternatively be assigned as two General Purpose Inputs or Outputs (GPIO2, GPIO3) that can be programmed to have any of the input or output control functions listed in GPIO Pin Descriptions. Regardless of whether Output 11 is functioning as a clock output or GPIO, the power supply will be VDDO4.				

Pin Name	Pin Number	Pin Type <sup>1</sup>	Function				
Serial Interface		I					
SDA/SDIO	37	I/O	Serial Data Interface This is the bidirectional data pin (SDA) for the I <sup>2</sup> C mode, or the bidirectional data pin (SDIO) in the 3-wire SPI mode, or the input data pin (SDI) in the 4-wire SPI mode. When in I <sup>2</sup> C mode, this pin must be pulled-up using an external resistor of at least 1 k $\Omega$ . No pull-up resistor is needed when in SPI mode.				
SCLK	38	I	Serial Clock Input Interface This is the bidirectional I <sup>2</sup> C clock pin. Clock stretching (i.e., driving SCL low to insert wait-states) will be utilized when operating at rates greater than 100 kHz. This pin must be pulled up to V <sub>DDIO</sub> using an external resistor of at least 1 k $\Omega$ .				
A0/CSb	41	I	Address Select 0/Chip Select This pin functions as the hardware controlled LSB of the device address (A0) in I <sup>2</sup> C mode. In SPI mode, this pin functions as the chip select input (active low). This pin is internally pulled-up and can be left floating if unused.				
A1/SDO/GPIO4	42	0	Address Select 1/ Serial Data Output/GPIO4 This input pin operates as the hardware controlled next to LSB portion of the device address (A1) in I <sup>2</sup> C mode. In 4-wire SPI mode this pin operates as the serial data output (SDO). In 3-wire SPI mode this pin can function as an additional GPIO pin (GPIO4).				
Control/Status	1	I					
GPIO0	15						
GPIO1 GPIO2	16	Les Q	Programmable General Purpose Input or Outputs These pins can be programmed to the functions defined in GPIO Pin Descriptions.				
	17	l or O	See "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for more details.				
GPIO3	39						
RSTb	18	I	<b>Device Reset</b> This pin functions as an active-low reset input and is used to generate a device reset when held low for at least the specified Minimum Pulse Width. This resets the device back to a known state and reloads the NVM frequency plan and application. All clocks will stop while the RSTb pin is asserted. If there is no frequency plan in NVM, the reset pin will return the device to the bootloader state in which it is waiting for the frequency plan and application to be downloaded by the host controller. This pin accepts a CMOS input and is internally pulled up with a ~20 k $\Omega$ resistor to VDDIO. VDDA and VDD18 must be powered up and stable before releasing RSTb. RSTb must not be toggled faster than the maximum update rate (f <sub>UR</sub> ) specification. For more details on RSTb pin circuitry, refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual".				
Power		I					
VDDIN	1	Р	Input Clock Supply Voltage Supply voltage 3.3 V, 2.5 V or 1.8 V for the input clock buffers.				
VDDO1	4		Output Clock Supply Voltage 1–4				
VDDO2	11		Supply voltage 3.3 V, 2.5 V, or 1.8 V for outputs. Leave VDDO pins of unused output drivers unconnected. An alternate option is to connect the VDDO pin to a power supply and disciple the output drivers unconnective. The superior of the su				
VDDO3	24		and disable the output driver to minimize current consumption. A 0402 1 $\mu$ F capacitor should be placed very near each of these pins. VDDO may not exceed VDDA.				
			The banks of outputs are powered as follows:				
		Р	VDDO1 – OUT[0:2]				
	24		VDDO2 – OUT[3:4]				
VDDO4	31		VDDO3 – OUT[5:8]				
			VDDO4 – OUT[9:11] Data sheet jitter performance requires all outputs in a given bank to operate at a single frequency.				

### Table 1. Pin Descriptions (Continued)

Table 1. I III Descriptions (continueu)	Table 1.	Pin	Descriptions	(Continued)
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Pin Name	Pin Number	Pin Type <sup>1</sup>	Function	
VDDA	14	Ρ	<b>Core Analog Supply Voltage</b> This core supply can operate from a 3.3 V or 1.8 V power supply for low power mode. Note that all other supply voltages must be equal or lower voltage than the VDDA pin so in low power mode no other supply can exceed 1.8 V. See the "Fifth Generation DSPLL" Wireline Jitter Attenuator Reference Manual" for power supply filtering recommendations. A 0402 1 $\mu$ F capacitor should be placed very near each of these pins.	
VDD18	19		Core Supply Voltage 1.8 V	
VDD18	36	Р	The device core operates from a 1.8 V supply. See the "Fifth Generation DSPLL® Wirelin Jitter Attenuator Reference Manual" for power supply filtering recommendations. A	
VDD18	40		0402 1 $\mu\text{F}$ capacitor should be placed very near each of these pins.	
VDDIO	43	Ρ	Control, Status IO Clock Supply Voltage Supply voltage 3.3 V, 2.5 V, or 1.8 V for the serial interface, Control, and Status inputs and outputs.	
VDDXO	44	Ρ	<b>Reference Supply Voltage</b> Supply voltage of 3.3 V or 1.8 V supported for the reference. For best performance, VDDXO should be the same voltage as the VDD_XO.	
GND PAD	Package Bottom	Ρ	Exposed Die Attach Pad The exposed die attach pad (ePAD) on the bottom of the package must be connected to electrical ground.	

1. I = Input, O = Output, P = Power, N/C = No Connect.

# **3. Electrical Specifications**

All minimum and maximum specifications are guaranteed and apply across the recommended operating conditions. Typical values apply at nominal supply voltages and an operating temp of 25 °C unless otherwise noted.

Parameter	Symbol	Test Condition	Value	Unit
	V <sub>DDIN</sub>		-0.5 to 3.8	V
	V <sub>DDXO</sub>		-0.5 to 3.8	V
DC supply voltage	V <sub>DD18</sub>	<10 s	-0.5 to 2.4	V
	V <sub>DDA</sub>	<10 s	-0.5 to 3.8	V
	V <sub>DDO</sub>	<10 s	-0.5 to 3.8	V
	V <sub>DDIO</sub>	<10 s	-0.5 to 3.8	V
	V <sub>I1</sub>	XO_IN/INx/INxb	-0.85 to 3.8	V
Input voltage range	V <sub>I2</sub>	GPIO0-4, RSTb, SCLK, SDA/SDO/SDIO, A0/A1/CSb	-0.5 to 3.8	V
	V <sub>I3</sub>	XA/XB	-0.5 to 2.7	V
Latch-up tolerance	LU		JESD78 Compl	liant
ESD tolerance	HBM	100 pF, 1.5 kΩ	2.0	kV
Storage range	TSTG		-55 to 150	°C
Maximum junction temperature in operation	T <sub>JCT</sub>		125	°C
Soldering temperature (Pb-free profile) <sup>4</sup>	T <sub>PEAK</sub>		235 to 245	°C
Soldering time at T <sub>PEAK</sub> (Pb-free profile) <sup>4</sup>	Т <sub>Р</sub>		30 to 40	S

# Table 2. Absolute Maximum Ratings<sup>1,2,3</sup>

1. Exposure to maximum rating conditions for extended periods may reduce device reliability. Exceeding any of the limits listed here may result in permanent damage to the device.

2. RoHS-6 compliant.

3. For more packaging information, visit the Skyworks environmental compliance page.

4. The device is compliant with JEDEC J-STD-020.

ESD Handling: Industry-standard ESD handling precautions must be adhered to at all times to avoid damage to this device.

Derometor	Symphol	Test Condition	Туріса	Unit		
Parameter	Symbol	Test Condition	JEDEC <sup>1</sup>	CEVB <sup>2</sup>	onit	
		Still air	23.27	9.89	°C/W	
Thermal resistance (junction-to-ambient)	$\theta_{JA}$	1 m/s	19.44	8.60	°C/W	
		2 m/s	18.65	8.52	°C/W	
Thermal resistance (junction-to-board)	$\Psi_{JB}{}^{3}$	Still air	10.21	3.85	°C/W	
Thermal resistance (junction-to-top-center)	Ψ <sub>JC</sub>	Still air	0.4	0.6	°C/W	

### **Table 3. Thermal Conditions**

1. Based on PCB dimension: 4" x 4.5", PCB thickness: 1.6 mm, number of Cu Layers: 2.

Based of PCB dimension: 4 x 4.5 , PCB trickingss. 1.6 time, number of ucleavers. 2.
 Customer EVB: Ten-layer board, board dimensions: 9" x 9", all layers are copper-poured.
 Ψ<sub>JB</sub> can be used to calculate the junction temperature based on the board temperature and power dissipation for a given frequency plan, T<sub>j</sub> = T<sub>PCB</sub> + Ψ<sub>JB</sub> x P<sub>D</sub>. T<sub>PCB</sub> should be measured as close to the SKY63104/05/06 DUT as possible since temperature may vary across the PCB.

#### **Table 4. Recommended Operating Conditions**

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDX0} = V_{DDA} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low Power Mode:  $V_{DD18} = V_{DD10} = V_{DDX0} = V_{DDA} = V_{DD0} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Ambient temperature	Τ <sub>Α</sub>		-40	25	95	°C
Board temperature	Т <sub>В</sub>		-40	65	105	°C
Junction temperature	TJ <sub>MAX</sub> 1		_	_	125	°C
	V <sub>DD18</sub>		1.71	1.80	1.89	V
	V <sub>DDA</sub> <sup>2</sup>		3.14	3.30	3.47	V
Core supply voltage	♥ DDA	Low-power mode	1.71	1.80	1.89	V
	V <sub>DDXO</sub>		3.14	3.30	V <sub>DDA</sub> <sup>2</sup>	V
		Low-power mode	1.71	1.80	1.89	V
	V <sub>DDIN</sub>		3.14	3.30	V <sub>DDA</sub> <sup>2</sup>	V
Input supply voltage			2.38	2.50	2.62	V
			1.71	1.80	1.89	V
			3.14	3.30	V <sub>DDA</sub> <sup>2</sup>	V
GPIO supply voltage	V <sub>DDIO</sub>		2.38	2.50	2.62	V
			1.71	1.80	1.89	V
			3.14	3.30	V <sub>DDA</sub> <sup>2</sup>	V
Clock output driver supply voltage	V <sub>DDO</sub>		2.38	2.50	2.62	V
			1.71	1.80	1.89	V

1. Ambient temperature of 95 °C may not be possible with all configurations. This is dependent on device configuration. T<sub>i</sub> cannot exceed a max of 125 °C.

2. VDDA must be greater than or equal to the highest voltage applied to the device. In Low-Power Mode, all voltage supplies must be set to 1.8 V.

### Table 5. Performance Characteristics

 $V_{DD18} = 1.8 \text{ V} \pm 5\%$ ,  $V_{DDA} = V_{DDXO} = 3.3 \text{ V} \pm 5\%$ ; All other supplies programmable 3.3 V ±5%, 2.5 V ±5%, 1.8 V ±5%, T<sub>A</sub> = -40 to 95 °C. Low-Power Mode:  $V_{DD18} = V_{DDI0} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%$ , T<sub>A</sub> = -40 to 95 °C.

Parameter	Symbol	Comment	Min	Тур	Max	Unit
Initial start-up time	t <sub>START</sub>	Time from POR to when the device generates free-running clocks from NVM frequency plan.	_	25	40	ms
	t <sub>RDY</sub>	POR to API ready	—	25	30	ms
		DSPLLP, IN = 156.25 MHz, BW = 100 Hz FLOL deassert	_	0.40	0.52	S
		DSPLLP, IN = 156.25 MHz, BW = 100 Hz LOL deassert	_	1.30	1.60	S
PLL lock time <sup>1</sup>	+	DSPLLP, IN = 156.25 MHz, BW = 20 Hz FLOL deassert	_	0.42	0.58	S
	t <sub>ACQ</sub>	DSPLLP, IN = 156.25MHz, BW = 20 Hz LOL deassert	_	2.62	2.90	S
		DSPLLA/B, IN = 156.25 MHz, BW = 200 Hz FLOL deassert	_	0.40	0.47	S
		DSPLLA/B, IN = 156.25 MHz, BW = 200 Hz LOL deassert	_	0.99	1.20	S
		Range <sup>2</sup>	-T <sub>VCO</sub> x 127	_	+T <sub>VCO</sub> x 127	ps
Output delay adjustment	t <sub>ODIV</sub>	Resolution		T <sub>VCO</sub>	-	ps
		Resolution (fine delay enabled)		T <sub>VCO/4</sub>	-	ps
Jitter peaking	J <sub>PK</sub>	All PLLs	—	_	0.1	dB
Maximum phase transient during hitless switch <sup>3</sup>	t <sub>SWITCH</sub>		-	35	150	ps
Pull-in range	ω <sub>P</sub>		—	±100	—	ppm
Absolute input-to-output	t <sub>ZDELAY</sub>	DSPLLP, DSPLLA, DSPLLB (ZDM)	-100	_	100	ps
delay + variation <sup>4,5</sup>	t <sub>IODELAY</sub>	DSPLLP (Non ZDM)	-400	_	400	ps
Input-to-output delay variation <sup>6</sup>	t <sub>IODELAY_VAR</sub>	DSPLLA, DSPLLB (Non ZDM)	-500	_	500	ps

#### Table 5. Performance Characteristics (Continued)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%$ ,  $V_{DDA} = V_{DDXO} = 3.3 \text{ V} \pm 5\%$ ; All other supplies programmable 3.3  $\text{V} \pm 5\%$ , 2.5  $\text{V} \pm 5\%$ , 1.8  $\text{V} \pm 5\%$ ,  $T_A = -40$  to 95 °C. Low-Power Mode:  $V_{DD18} = V_{DDI0} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%$ ,  $T_A = -40$  to 95 °C.

Parameter	Symbol	Comment	Min	Тур	Max	Unit
		625 MHz	—	54	84	fs
		390.625 MHz	_	54	75	fs
	Q Div	312.5 MHz	_	54	72	fs
		156.25 MHz	_	55	77	fs
DSPLLP RMS jitter		125 MHz	_	60	80	fs
12 kHz to 20 MHz <sup>7</sup>	NA/NB Div	156.25 MHz	-	65	85	fs
		125 MHz	_	80	100	fs
		100 MHz	_	95	155	fs
		322.265625 MHz	-	75	95	fs
		644.53125 MHz	-	65	80	fs
DSPLLP RMS jitter	Q Div	625 MHz	_	18	-	fs
with 4 MHz high-pass filter 12 kHz to 20 MHz <sup>7</sup>	Q DIV	312.5 MHz	_	22	_	fs
DSPLLA/B RMS jitter	NA/NB Div	156.25 MHz	_	110	140	fs
12 kHz to 20 MHz <sup>7</sup>	NATING DIV	155.52 MHz	_	115	150	fs

1. FLOL deasserts once frequency lock is achieved. LOL deasserts once both frequency and phase lock are achieved. Refer to "5.12.2. Lock Acquisition Mode" on page 40 for more details on LOL thresholds.

2. Output delay adjustment range will vary depending on frequency plan. Output delay adjustment range (ns) is displayed in the "Output Skew Control" step of the CBPro Wizard. f<sub>VCO</sub> range is 10.4 to 13.0 GHz.

3. Phase transient specification only applies to clock switches between two synchronous inputs to a DSPLL configured for a phase buildout clock switching mode in CBPro.

4. Input-to-output (IO) delay is measured at the output driver with respect to the input after the output phase has achieved a steady-state value.

5. I/O delay requires clock switching to be configured for Phase Pull-in in CBPro. IO delay is not specified for Phase Buildout (hitless) clock switching mode.

6. Only I/O delay VARIATION is specified for DSPLLA, DSPLLB. Absolute IO delay is dependent on frequency plan.

7. Jitter generation test conditions: XTAL = 54 MHz TXC 7X54070001: f<sub>VCO</sub> < 11 GHz: f<sub>OUT</sub> LVDS, DSPLLP BW = 40 Hz.

### Table 6. 100 MHz PCIe Jitter Performance Characteristics (without Spread Spectrum)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDA} = V_{DDXO} = 3.3 \text{ V} \pm 5\%; \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low-Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Comment	Min	Тур	Max	PCI-SIG Limit <sup>1</sup>	Unit
		Gen 1 (2.5GT/s)	-	14	56	86	ps P-P
		Gen 2 (5GT/s) Low Band	_	2	29	3000	fs <sub>RMS</sub>
		Gen 2 (5GT/s) High Band	_	86	860	3100	fs <sub>RMS</sub>
	DSPLLP + Qdiv	Gen 3 (8GT/s)	_	24	172	1000	fs <sub>RMS</sub>
		Gen 4 (16GT/s)	-	23	172	500	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	-	6	46	150	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	-	6	40	100	fs <sub>RMS</sub>
100 MHz PCIe common clock		Gen 7 (128GT/s)	-	4	28	67	fs <sub>RMS</sub>
jitter performance <sup>2</sup>		Gen 1 (2.5GT/s)	-	14	57	86	ps P-P
		Gen 2 (5GT/s) Low Band	_	2	30	3000	fs <sub>RMS</sub>
	DSPLLP + NA/NB Div	Gen 2 (5GT/s) High Band	_	117	901	3100	fs <sub>RMS</sub>
	DSPLLA DSPLLB	Gen 3 (8GT/s)	-	34	182	1000	fs <sub>RMS</sub>
		Gen 4 (16GT/s)	-	33	182	500	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	_	12	49	150	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	-	8	42	100	fs <sub>RMS</sub>
		Gen 7 (128GT/s)	-	6	29	67	fs <sub>RMS</sub>
		Gen 2 (5GT/s) Low Band	_	3	5	2120	fs <sub>RMS</sub>
		Gen 2 (5GT/s) High Band	_	117	646	2190	fs <sub>RMS</sub>
	DSPLLP + Qdiv	Gen 3 (8GT/s)	-	30	129	707	fs <sub>RMS</sub>
		Gen 4 (16GT/s)	-	30	129	495	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	-	11	54	177	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	-	10	54	106	fs <sub>RMS</sub>
100 MHz PCIe separate reference clock jitter		Gen 7 (128GT/s)	-	7	38	71	fs <sub>RMS</sub>
performance <sup>2</sup>		Gen 2 (5GT/s) Low Band	_	3	5	2120	fs <sub>RMS</sub>
		Gen 2 (5GT/s) High Band	_	142	679	2190	fs <sub>RMS</sub>
	DSPLLP + NA/NB Div DSPLLA	Gen 3 (8GT/s)	-	37	137	707	fs <sub>RMS</sub>
	DSPLLA DSPLLB	Gen 4 (16GT/s)	-	37	137	495	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	-	15	57	177	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	-	12	57	106	fs <sub>RMS</sub>
		Gen 7 (128GT/s)	_	9	40	71	fs <sub>RMS</sub>

1. PCI-SIG does not specify a jitter limit for separate reference clock architectures. Instead the PCI-SIG specified simulation limit can be split evenly between transmitter and receiver clocks by dividing by the square root of 2 since their jitter is uncorrelated.

2. Jitter integration as specified by PCI-SIG in the PCI Express® Base Specification Revision 7.0.

#### Table 7. 100 MHz PCIe Jitter Performance Characteristics (with Spread Spectrum)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDA} = V_{DDXO} = 3.3 \text{ V} \pm 5\%; \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low-Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Comment	Min	Тур	Max	PCI-SIG Limit <sup>1</sup>	Unit
		Gen 1 (2.5GT/s)	—	26	70	86	ps P-P
		Gen 2 (5GT/s) Low Band	_	5	43	3000	fs <sub>RMS</sub>
		Gen 2 (5GT/s) High Band	_	684	1880	3100	fs <sub>RMS</sub>
100 MHz PCIe common clock jitter performance <sup>2,3</sup>	DSPLLP + NB Div	Gen 3 (8GT/s)	_	272	459	1000	fs <sub>RMS</sub>
		Gen 4 (16GT/s)	_	191	326	500	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	—	55	103	150	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	_	37	72	100	fs <sub>RMS</sub>
		Gen 7 (128GT/s)	_	26	51	67	fs <sub>RMS</sub>
		Gen 2 (5GT/s) High Band	_	838	1047	2190	fs <sub>RMS</sub>
		Gen 3 (8GT/s)	—	619	656	707	fs <sub>RMS</sub>
100 MHz PCIe separate reference clock jitter performance <sup>2,4</sup>	DSPLLP + NB Div	Gen 4 (16GT/s)	_	394	463	495	fs <sub>RMS</sub>
		Gen 5 (32GT/s)	—	66	92	177	fs <sub>RMS</sub>
		Gen 6 (64GT/s)	—	59	82	106	fs <sub>RMS</sub>
		Gen 7 (128GT/s)	_	42	58	71	fs <sub>RMS</sub>

1. PCI-SIG does not specify a jitter limit for separate reference clock architectures. Instead the PCI-SIG specified simulation limit can be split evenly between transmitter and receiver clocks by dividing by the square root of 2 since their jitter is uncorrelated.

Jitter integration as specified by PCI-SIG in the PCI Express<sup>®</sup> Base Specification Revision 7.0.

3. Common Clock spread spectrum modulation of -0.4%.

4. Separate Reference spread modulation of -0.4% Gen2 to Gen4, -0.3% Gen5 to Gen6, and -0.15% Gen7.

### Table 8. DC Characteristics

$V_{DD18} = 1.8 V \pm 5\%$ , $V_{DDX0} = V_{DDA} = 3.3 V \pm 5\%$ , All other supplies programmable 3.3 V ±5%, 2.5 V ±5%, 1.8 V ±5%, T <sub>A</sub> = -40 to 95 °C.
Low Power Mode: $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 V \pm 5\%$ , $T_A = -40$ to 95 °C.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
		SKY63104 <sup>1,2</sup>	_	375	635	mA
	I <sub>DD18</sub>	SKY63105 <sup>1,2</sup>		400	660	mA
		SKY63106 <sup>1,2</sup>	_	415	670	mA
Core supply current		SKY63104 <sup>1,2</sup>	_	200	230	mA
$(V_{DD18} + V_{DDA})$	I <sub>DDA</sub>	SKY63105 <sup>1,2</sup>	_	200	230	mA
		SKY63106 <sup>1,2</sup>	_	200	230	mA mA mA
	I <sub>DD18_PD</sub>	RSTb = 0	_	120	300	mA
	I <sub>DDA_PD</sub>	RSTb = 0	_	15	16	mA
		SKY63104 <sup>1,2</sup>	_	45	60	mA
	I <sub>DDIN</sub> + I <sub>DDIO</sub>	SKY63105 <sup>1,2</sup>	_	52	67	mA
		SKY63106 <sup>1,2</sup>	_	60	77	mA
Peripheral supply current (V <sub>DDIN</sub> + V <sub>DDIO</sub> + V <sub>DDXO</sub> )		SKY63104 <sup>1,2</sup>	_	10	14	mA
	I <sub>DDXO</sub>	SKY63105 <sup>1,2</sup>	_	10	14	mA
		SKY63106 <sup>1,2</sup>	_	10	14	mA
	I <sub>DDIN_PD</sub> + I <sub>DDIO_PD</sub> + I <sub>DDXO_PD</sub>	RSTb = 0	_	1	4	mA
		LVPECL (2.5 V, 3.3 V) @ 156.25 MHz <sup>3</sup>	_	24	26	mA
		LVDS (2.5 V, 3.3 V) @ 156.25 MHz <sup>3</sup>	_	13	15	mA
		S-LVDS (1.8 V) @ 156.25 MHz <sup>3</sup>	_	12	14	mA
Output buffer supply	I <sub>DDOX</sub> (per output)	CML (1.8 V, 2.5 V, 3.3 V) @ 156.25 MHz <sup>3</sup>	—	14	17	mA
current (V <sub>DDOX</sub> )		3.3 V LVCMOS @ 156.25 MHz <sup>4</sup>	_	19	22	mA
		2.5 V LVCMOS @ 156.25 MHz <sup>4</sup>	_	15	17	mA
		1.8 V LVCMOS@ 156.25 MHz <sup>4</sup>	_	11	12	mA
		HCSL internal termination (1.8 V, 2.5 V, 3.3 V) @ 156.25 MHz <sup>5</sup>	_	20	23	mA
	I <sub>DDOX_PD</sub>	RSTb = 0	_	0.23	0.3	mA

### Table 8. DC Characteristics (Continued)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol Test Condition		Min	Тур	Max	Unit
Tablaansa dininaking		SKY63104 <sup>1</sup>	_	1.9	2.8	W
		SKY63105 <sup>1</sup>	—	2	2.9	W
	D	SKY63106 <sup>1</sup>	—	2	2.9	W
Total power dissipation	P <sub>D</sub>	SKY63104 low-power mode <sup>2</sup>		1.4	2.0	W
		SKY63105 low-power mode <sup>2</sup>		1.4	2.0	W
		SKY63106 low-power mode <sup>2</sup>		1.4	2.0	W
Supply voltage ramp rate	T <sub>VDD</sub>	Fastest V <sub>DD</sub> ramp rate allowed on startup	_	_	100	V/ms

1. Typical test configuration: The following frequencies on 12 LVDS outputs: 4–156.25 MHz (Q), 2–312.5 MHz (Q), 1–125 MHz (Q), 1–100 MHz (NB), 1–50 MHz (NB), 2–644. 53125 MHz (NA), 1–322.265625 MHz (NA). Excludes power in termination resistors. VDDIN = 1.8 V; VDDO = 3.3 V.

Typical test configuration: Same as Note 1, except all supplies set to 1.8 V for Low-Power Mode. Output formats changed to S-LVDS format.

3. Differential outputs terminated into an ac-coupled differential 100  $\Omega$  load.

4. LVCMOS outputs measured into a 5-inch, 50  $\Omega$  PCB trace with 5 pF load.

5. No external termination; amplitude 800 mVpp\_se.

#### **Table 9. Input Specifications**

 $V_{DD18} = 1.8 V \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 V \pm 5\%, All other supplies programmable 3.3 V \pm 5\%, 2.5 V \pm 5\%, 1.8 V \pm 5\%, T_A = -40 to 95 °C.$ Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 V \pm 5\%, T_A = -40 to 95 °C.$ 

Parameter	Symbol	Test Condition	Min	Тур	Max	Units		
LVCMOS (XO Applied to XO_IN)								
Input frequency range	f <sub>IN_CMOS</sub>		30.72	_	250	MHz		
Slew rate <sup>1,2,3</sup>	SR		0.75	_	_	V/ns		
Input voltage	V <sub>IL</sub>		-	_	V <sub>DDXO</sub> x 0.3	V		
input voltage	V <sub>IH</sub>		V <sub>DDXO</sub> x 0.7	_	_	V		
Input resistance	R <sub>IN</sub>		—	63	—	kΩ		
Duty cycle	DC		40	_	60	%		
Capacitance	C <sub>IN_SE</sub>		—	1.25	-	pF		
Crystal (Connected to XA/XB Pi	ns) <sup>4</sup>							
Frequency range	f <sub>IN_XTAL</sub>		48	—	61.44	MHz		
Load capacitance	CL		—	8	-	pF		
Crystal drive level	dL		—	_	200	μW		
Equivalent series resistance	R <sub>ESR</sub>		Refer to the "Recommended XTAL, XO, VCXO, TCXO, and OCXO Reference Manual" to determine ESR and Shunt Capacitance Values.					
Shunt capacitance	CO							

### Table 9. Input Specifications (Continued)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Test Condition	Min	Тур	Мах	Units
Differential (INx/INxb)						
	f <sub>IN_DIFF</sub>	Differential, AC coupled	0.008	—	1000	MHz
Input frequency range	f <sub>IN_SE</sub>	Single-ended, AC coupled	0.008	_	250	MHz
Veltage guing	V <sub>IN_DIFF</sub>	Differential, AC coupled	200	350 (LVDS) 800 (LVPECL)	1800	mVpp_se
Voltage swing	V <sub>IN_SE</sub>	Single-ended, AC coupled	400	1600	1800	mVpp_se
Slew rate <sup>3, 5</sup>	SR		0.4	_	_	V/ns
Duty cycle	DC		40	_	60	%
Capacitance	C <sub>IN_DIFF</sub>		-	2.5	-	pF
LVCMOS (INx/INxb)						
Input frequency range	f <sub>IN_LVCMOS</sub>		0.008	—	250	MHz
Slew rate <sup>3,5</sup>	SR		0.2	0.4	-	V/ns
Input voltage	V <sub>IL</sub>		_	_	V <sub>DDIN</sub> x 0.3	V
Input voltage	V <sub>IH</sub>		V <sub>DDIN</sub> x 0.7	_	_	V
Input resistance	R <sub>IN</sub>		-	63	-	kΩ
Duty cycle	DC		40	_	60	%
Capacitance	C <sub>IN_SE</sub>		-	1.25	-	pF
Other Control Input Pins: RSTb, F	INC, FDEC, OE, PL	Lx_FORCE_HO, PLLx_INSEL[#],	IN_FAIL[#]			
Undete rete	£	RSTb <sup>6</sup>	-	_	1	Hz
Update rate	f <sub>UR</sub>	FINC, FDEC	-	_	800	kHz
Input voltage	V <sub>IL</sub>		-	-	V <sub>DDIO</sub> x 0.3	V
Input voltage	V <sub>IH</sub>		V <sub>DDIO</sub> x 0.7	-	-	V
Minimum pulse width	PW		150	—	-	ns
Programmable internal pullup, pulldown <sup>7</sup>	R <sub>IN</sub>			20		kΩ

1. The minimum slew rate on the XO applied to XO\_IN is recommended to meet the specified jitter performance.

2. To achieve this slew rate and voltage swing, use one of the XOs from the "Recommended XTAL, XO, VCXO, TCXO, and OCXO Reference Manual" placed as close as possible to the XO IN pins.

Slew rate can be estimated using the following simplified equation: SR = ((0.8 - 0.2) x V<sub>IN\_VPP\_se</sub>)/t<sub>r</sub>.
 To meet specified jitter performance use one of the XTALs from the "Recommended XTAL, XO, VCXO, TCXO, and OCXO Reference Manual".

5. The minimum slew rate on the input clock applied to INx/INxb is recommended to meet the specified input-to-output delay performance.

6. Glitches and toggles on RSTb more frequent than f<sub>UR</sub> may cause the device to lock up in reset. Power cycle the device to restore operation.

7. When Output is configured as a GPIO, the Programmable internal pullup, pulldown valus is 50 k $\Omega$  typical.

### **Table 10. Differential Clock Output Specifications**

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable} = 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Test Conc	lition	Min	Тур	Max	Units
		Q divider <sup>1</sup> (Grade A/B/C)		0.008	-	3200	MHz
Output frequency	f <sub>оит</sub>	NA divider, NB divider <sup>2</sup>		0.008	_	650	MHz
	56	f < 400 MHz		49.5	50.0	50.5	%
Duty cycle	DC	400 MHz < f < 3.2 GHz		48.0	50.0	52.0	%
		Q divider outputs, same differer	ntial format				
Output-to-output skew	т <sub>sк</sub>	MultiSynth (NA or NB) outputs, same differential format, same I	MultiSynth	-50	_	50	ps
		VDDO = 3.3 V	LVPECL, LVDS, CML, custom differential,	-6	—	6	ps
		VDDO = 2.5 V	$f \le 160 \text{ MHz}$	-5	_	25	ps
OUT-OUTb skew <sup>3</sup>	T <sub>sk_OUT</sub>	VDDO = 3.3 V/2.5 V	LVPECL, LVDS, CML, custom differential, f > 160 MHz	-10	_	15	ps
		VDDO = 1.8 V	/DDO = 1.8 V CML, S-LVDS, custom differential, All frequencies		_	30	ps
		VDDO = 3.3 V/2.5 V	LVDS	330xSF	360xSF	380xSF	mVpp_se
Output voltage swing <sup>4</sup>		VDDO = 1.8 V	S-LVDS	350xSF	370xSF	410xSF	mVpp_se
	V <sub>OUT</sub>	VDDO = 3.3 V/2.5 V	AC-coupled LVPECL	780xSF	840xSF	910xSF	mVpp_se
		VDDO = 3.3 V/2.5 V/1.8 V	CML	390xSF	420xSF	460xSF	mVpp_se
		VDDO = 3.3 V/2.5 V	Custom differential, 600 mVpp_se	560xSF	630xSF	710xSF	mVpp_se
		f < 500 MHz		0.9	1	1	SF
Output voltage swing scaling factor (SF) OUT0-11	SF	500 MHz < f < 1.5 GHz	500 MHz < f < 1.5 GHz		0.9	0.95	SF
		1.5 GHz < f < 3.2 GHz		0.5	0.6	0.75	SF
Common mode voltage	V <sub>CM</sub>	VDDO = 3.3 V/2.5 V	LVDS, AC-coupled LVPECL, custom differential, CML	1.15	1.20	1.25	v
		VDDO = 1.8 V	S-LVDS, CML	0.85	0.90	0.95	V
		VDDO = 3.3 V/2.5 V	AC-coupled LVPECL	_	125	260	ps
		VDDO = 3.3 V/2.5 V, f<100 MHz	LVDS, custom differential	_	125	260	ps
Rise and fall times	+ /+.	VDDO = 3.3 V/2.5 V, f≥100 MHz		_	125	200	ps
(20% to 80%) OUT0-11	t <sub>r</sub> /t <sub>f</sub>	VDDO = 1.8 V, f<500 MHz	S-LVDS	-	150	250	ps
		VDDO = 1.8 V, f <u>&gt;</u> 500 MHz	J-LV <i>U</i> J	_	125	200	ps
		VDDO = 3.3 V/2.5 V/1.8 V	CML	-	150	280	ps
Differential output impedance	Z <sub>O</sub>	Differential formats		-	100	_	Ω

#### Table 10. Differential Clock Output Specifications (Continued)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable} = 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C.}$ Low Power Mode:  $V_{DD18} = V_{DD1N} = V_{DD10} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C.}$ 

Parameter	Symbol	Symbol Test Condition		Тур	Max	Units
Power supply noise rejection <sup>5</sup>		25 kHz sinusoidal noise	-	-94	-	dBc
	PSR	100 kHz sinusoidal noise	-	-95	-	dBc
	FJN	500 kHz sinusoidal noise	_	-91	-	dBc
		1 MHz sinusoidal noise	_	-91	_	dBc
Output-to-output crosstalk <sup>6</sup>	XTALK <sub>OUT</sub>	Differential outputs, same format	-	-95	_	dBc
Input-to-output crosstalk <sup>7</sup>	XTALK <sub>IN</sub>	Differential input and output, same format	_	-90		dBc

1. Q dividers support output frequencies within the specified range equal to  $f_{VCO}/Q$ , where Q is an integer.

2. NA, NB MultiSynths support any output frequency within the specified range.

Skew between positive and negative output pins.

4. Output voltage swing is dependent on frequency range. Scale all values by the Output Voltage Swing Scaling Factor (SF). Voltage swing is specified in mVpp\_SE as shown in the following figure.



5. Measured for a 156.25 MHz LVDS output frequency. 100 mVpp sine wave noise added to VDDO = 3.3 V and noise spur amplitude measured.

6. Crosstalk spur measured with the victim running at 156.25 MHz and the aggressor at 155.52 MHz. Victim and aggressor are separated by two unused channels.

7. Crosstalk spur measured with the victim running at 156.25 MHz on OUTO and the aggressor at 155.52 MHz on IN3.

### Table 11. HCSL Clock Output Specifications

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDIN} = V_{DDIO} = 3.3 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, V_{DDREF} = V_{DDA} = 3.3 \text{ V} \pm 5\%, V_{DDO} = 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol		Tes	t Condition	Min	Тур	Max	Units
Output frequency	f <sub>OUT</sub>	Q divider, NA divide	r, NB divider <sup>1</sup>		0.008	—	500	MHz
Dutu susla	DC	f < 400 MHz			49.5	50.0	50.5	%
Duty cycle	DC	400 MHz < f < 500 N	ЛНz		48.0	50.0	52.0	%
Output-to-output	-	Q divider outputs, s	ame differentia	l format	-50	-	50	ps
skew	т <sub>sк</sub>	MultiSynth (NA or N	IB) outputs, san	ne differential format, same MultiSynth	-50	-	50	ps
				HCSL standard, 800 mVpp_se, int term	—	-	15	ps
			VDDO = 3.3 V	HCSL standard, 800 mVpp_se, ext term	-	_	25	ps
				HCSL fast, 800 mV or 1200 mV, ext term	-	—	10	ps
OUT-OUTb skew <sup>2</sup> T <sub>SK_O</sub>		Skew between		HCSL standard, 800 mVpp_se, int term	-	_	15	ps
	T <sub>SK_OUT</sub>	positive and negative output	VDDO = 2.5 V	HCSL standard, 800 mVpp_se, ext term	-	—	30	ps
		pins		HCSL fast, 800 mV or 1200 mV, ext term	-	—	20	ps
			-	HCSL standard, 800 mVpp_se, int term	-	-	22	ps
			VDDO = 1.8 V	HCSL standard, 800 mVpp_se, ext term	-	—	70	ps
				HCSL fast, 800 mV, ext term	-	-	36	ps
		VDDO = 3.3 V/2.5 V/	/1.8 V	HCSL standard, 800 mVpp_se, int term	740xSF	810xSF	1000xSF	mVpp_se
Output voltage	N	VDDO = 3.3 V/2.5 V/	/1.8 V	HCSL standard, 800 mVpp_se, ext term	730xSF	810xSF	1000xSF	mVpp_se
swing <sup>3</sup>	V <sub>OUT</sub>	VDDO = 3.3 V/2.5 V		HCSL fast, 800 mVpp_se, ext term	730xSF	810xSF	1000xSF	mVpp_se
		VDDO = 3.3 V/2.5 V		HCSL fast, 1200 mVpp_se, ext term	1100xSF	1175xSF	1260xSF	mVpp_se
		f < 8 kHz			1	1	1	SF
Output voltage swing Scaling		8 kHz < f < 100 MHz			0.91	0.94	0.96	SF
Factor (SF) Standard,	SF	100 MHz < f < 200 MHz			0.89	0.91	0.93	SF
800 mVpp_se, int term OUT0-17			200 MH	lz < f < 400 MHz	0.83	0.85	0.92	SF
		f > 400 MHz			0.74	0.78	0.89	SF
				f < 8 kHz	1	1	1	SF
Output voltage swing Scaling			8 kHz	< f < 100 MHz	0.97	0.96	0.96	SF
Factor (SF) Standard,	SF		100 MH	lz < f < 200 MHz	0.94	0.93	0.95	SF
800 mVpp_se, ext term OUT0-17			200 MH	łz < f < 400 MHz	0.91	0.90	0.88	SF
			f:	> 400 MHz	0.68	0.71	0.75	SF
				f < 8 kHz	1	1	1	SF
Output voltage swing			8 kHz	< f < 100 MHz	0.98	0.99	0.96	SF
Scaling Factor (SF) Fast, 800 or	SF		100 MH	łz < f < 200 MHz	0.94	0.94	0.95	SF
1200 mVpp_se, ext term OUT0-17			200 MH	łz < f < 400 MHz	0.94	0.95	0.94	SF
			f	> 400 MHz	0.89	0.92	0.91	SF

#### Table 11. HCSL Clock Output Specifications (Continued)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDIN} = V_{DDIO} = 3.3 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, V_{DDREF} = V_{DDA} = 3.3 \text{ V} \pm 5\%, V_{DDO} = 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Tes	t Condition	Min	Тур	Max	Units
Common mode	V	VDDO = 3.3 V/2.5 V/1.8 V	HCSL 800 mVpp_se	0.35	0.425	0.52	V
voltage	V <sub>CM</sub>	VDDO = 3.3 V/2.5 V	HCSL 1200 mVpp_se	0.55	0.6	0.68	V
Rise and fall times		VDDO=3.3 V/2.5 V/1.8 V	HCSL fast, 800 or 1200 mVpp_se, ext term	_	270	360	ps
(20% to 80%) t <sub>r</sub> /t <sub>f</sub>	t <sub>r</sub> /t <sub>f</sub>	VDDO=3.3 V/2.5 V/1.8 V	HCSL standard, 800 mVpp_se, ext term	_	450	700	ps
OUT0-11		VDDO=3.3 V/2.5 V/1.8 V	HCSL standard, 800 mVpp_se, int term	-	270	420	ps
Differential		HCSL standard slew rate, int term			100		Ω
output impedance	z <sub>o</sub>	HCSL standard slew rate, ext term		-	Hi-Z	-	Ω
Impedance		HCSL fast slew rate, ext term			200	-	Ω
Output-to-output crosstalk <sup>4</sup>	XTALK <sub>OUT</sub>	Differential o	_	-95	_	dBc	
Input-to-output crosstalk <sup>5</sup>	XTALK <sub>IN</sub>	HCSL input an	d output, same format	_	-90	_	dBc

1. NA, NB MultiSynths support any output frequency within the specified range.

2. Skew between positive and negative output pins.

3. Output voltage swing is dependent on frequency range, HCSL slew rate, and HCSL termination settings. Scale all voltage swing values by the scaling factor (SF). Voltage swing is specified in mVpp\_SE as shown in the following figure.



4. Crosstalk spur measured with the victim running at 156.25 MHz and the aggressor at 155.52 MHz. Victim and aggressor are separated by two unused channels.

5. Crosstalk spur measured with the victim running at 156.25 MHz on OUT0 and the aggressor at 155.52 MHz on IN3.

#### Table 12. LVCMOS Clock Output Specifications

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDA} = V_{DDXO} = 3.3 \text{ V} \pm 5\%, \text{ All other supplies programmable} = 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C.}$ Low Power Mode:  $V_{DD18} = V_{DD1N} = V_{DD10} = V_{DDXO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C.}$ 

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
Output frequency	f	Q divider <sup>1</sup>	0.008	_	250	MHz
	f <sub>оит</sub>	NA or NB divider <sup>2</sup>	0.008	_	250	MHz
Duty cycle	DC	f < 100 MHz	49.5	_	50.5	%
	DC	100 MHz < f < 250 MHz	45	_	55	%
Output voltage high <sup>3</sup>	V <sub>OH</sub>	VDDO = 3.3 V/2.5 V/1.8 V	V <sub>DDO</sub> x 0.85	_	_	V
Output voltage low <sup>3</sup>	V <sub>OL</sub>	l <sub>OH</sub> = -8/-6/-4 mA, l <sub>OL</sub> = 8/6/4 mA	_	_	V <sub>DDO</sub> x 0.15	V
Rise and fall times (20% to 80%) <sup>4,5</sup>	t <sub>r</sub> /t <sub>f</sub>	LVCMOS	0.35	0.8	1.35	ns

1. Q dividers support output frequencies within the specified range equal to f<sub>VCO/Q</sub> where Q is an integer.

2. NA, NB MultiSynths support any output frequency within the specified range.

3.  $V_{OL}/V_{OH}$  is measured at  $I_{OL}/I_{OH}$  as shown in the DC Test Configuration portion of the drawing below.

A 15 to 25 Ω series termination resistor (Rs) is recommended to help match the source impedance to a 50 Ω PCB trace. A 5 pF capacitive load is assumed as shown in the AC Test Configuration portion of the drawing below.

#### **DC Test Configuration**

Zs V<sub>OL</sub>/V<sub>OH</sub>



**AC Test Configuration** 

5. SRL LVCMOS format clocks are intended only for low frequency clock applications.

#### **Table 13. Output Status Pin Specifications**

VDDIO = 3.3 V ±5%, 2.5 V ±5%, 1.8 V ±5%,  $T_A$  = -40 to 95 °C. Low-Power Mode: VDDIO = 1.8 V ±5%.

Parameter	Symbol	Test Condition	Min	Тур	Мах	Units
Status Output Pins (GPIO, SDA)						
Output voltage high <sup>1</sup>	V <sub>OH</sub>	I <sub>OH</sub> = -2 mA	V <sub>DDIO</sub> x 0.85	_	_	V
Output voltage low	V <sub>OL</sub>	I <sub>OL</sub> = 2 mA	_	—	V <sub>DDIO</sub> x 0.15	V

1. The  $V_{OH}$  specification does not apply to the open-drain SDA output when the serial interface is in  $l^2C$  mode.  $V_{OL}$  remains valid in all cases.

# Table 14. I<sup>2</sup>C Timing Specifications (SCL, SDA)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%, V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%; \text{ All other supplies programmable } 3.3 \text{ V} \pm 5\%, 2.5 \text{ V} \pm 5\%, 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%, T_A = -40 \text{ to } 95 \text{ °C}.$ 

Parameter	Symbol	Test Condition	Standard Mode 100 kbps		Fast Mode 400 kbps		Unit
			Min	Max	Min	Max	
SCL clock frequency	f <sub>SCL</sub>		—	100	—	400	kHz
SMBus timeout	_		25	35	25	35	ms
Hold time (repeated) START condition	t <sub>HD:STA</sub>		4.0	-	0.6	-	μs
Low period of the SCL clock	t <sub>LOW</sub>		4.7	-	1.3	-	μs
HIGH period of the SCL clock	t <sub>HIGH</sub>		4.0	-	0.6	-	μs
Setup time for a repeated START condition	t <sub>SU:STA</sub>		4.7	-	0.6	-	μs
Data hold time	t <sub>HD:DAT</sub>		100	-	100	-	ns
Data setup time	t <sub>SU:DAT</sub>		250	-	100	-	ns
Rise time of both SDA and SCL signals	t <sub>r</sub>		-	1000	20	300	ns
Fall time of both SDA and SCL signals	t <sub>f</sub>		—	300	-	300	ns
Setup time for STOP condition	t <sub>su:sto</sub>		4.0	-	0.6	-	μs
Bus free time between a STOP and START condition	t <sub>BUF</sub>		4.7	_	1.3	_	μs
Data valid time	t <sub>VD:DAT</sub>		-	3.45	-	0.9	μs
Data valid acknowledge time	t <sub>VD:ACK</sub>		—	3.45	-	0.9	μs



Figure 5. I<sup>2</sup>C Serial Port Timing Standard and Fast Modes

### Table 15. SPI Timing Specifications (4-Wire)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%$ ,  $V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%$ , All other supplies programmable 3.3 V  $\pm 5\%$ , 2.5 V  $\pm 5\%$ , 1.8 V  $\pm 5\%$ , T<sub>A</sub> = -40 to 95 °C. Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%$ , T<sub>A</sub> = -40 to 95 °C.

Parameter	Symbol	Min	Тур	Max	Unit
SCLK frequency	f <sub>SPI</sub>	-	_	30	MHz
SCLK duty cycle	T <sub>DC</sub>	40	_	60	%
SCLK period	T <sub>C</sub>	33.333	_	_	ns
Delay time, SCLK Fall to SDO active	T <sub>D1</sub>	_	12.5	20	ns
Delay time, SCLK Fall to SDO	T <sub>D2</sub>	-	10	15	ns
Delay time, CSb rise to SDO tri-state	T <sub>D3</sub>	_	10	20	ns
Setup time, CSb to SCLK	T <sub>SU1</sub>	5	_	_	ns
Hold time, SCLK Fall to CSb	T <sub>H1</sub>	5	_	—	ns
Setup time, SDI to SCLK rise	T <sub>SU2</sub>	5	_	_	ns
Hold time, SDI to SCLK rise	T <sub>H2</sub>	5	—	—	ns
Delay time between chip selects (CSb)	T <sub>CS</sub>	5	_	_	μs



Figure 6. SPI Serial Interface Timing (4-Wire)

### Table 16. SPI Timing Specifications (3-Wire)

 $V_{DD18} = 1.8 \text{ V} \pm 5\%$ ,  $V_{DDXO} = V_{DDA} = 3.3 \text{ V} \pm 5\%$ , All other supplies programmable 3.3 V  $\pm 5\%$ , 2.5 V  $\pm 5\%$ , 1.8 V  $\pm 5\%$ , T<sub>A</sub> = -40 to 95 °C. Low Power Mode:  $V_{DD18} = V_{DDIN} = V_{DDIO} = V_{DDA} = V_{DDO} = 1.8 \text{ V} \pm 5\%$ , T<sub>A</sub> = -40 to 95 °C.

Parameter	Symbol	Min	Тур	Max	Unit
SCLK frequency	f <sub>SPI</sub>	-	_	30	MHz
SCLK duty cycle	T <sub>DC</sub>	40	_	60	%
SCLK period	т <sub>с</sub>	33.33	—	-	ns
Delay time, SCLK fall to SDIO turn-on	T <sub>D1</sub>	-	12.5	20	ns
Delay time, SCLK fall to SDIO next-bit	T <sub>D2</sub>	—	10	15	ns
Delay time, CSb rise to SDIO tri-state	T <sub>D3</sub>	-	10	20	ns
Setup time, CSb to SCLK	T <sub>SU1</sub>	5	-	-	ns
Hold time, CSb to SCLK fall	T <sub>H1</sub>	5	_	-	ns
Setup time, SDI to SCLK rise	T <sub>SU2</sub>	5	—	-	ns
Hold time, SDI to SCLK rise	T <sub>H2</sub>	5	-	—	ns
Delay time between chip selects (CSb)	T <sub>CS</sub>	5	_	_	μs



Figure 7. SPI Serial Interface Timing (3-Wire)

# 4. Typical Operating Characteristics





-120.0

-130.0

-140.0

-150.0

-160.0 -170.0 -180.0

F Gain 50

M-1.5GHz]

LO Opt [<15 Figure 13. 64 fs Jitter for 125 MHz LVDS;

Path = DSPLLP + Qdiv

-120.0

-130.0

-140.0

-150.0

-160.0

Gain 50

Figure 12. 58 fs Jitter for 156.25 MHz LVPECL;

Path = DSPLLP + Qdiv



# 5. Functional Description

The SKY63104/05/06's 5th-generation DSPLLs provides jitter attenuation and any-frequency multiplication of the selected input frequency. Fractional input dividers (P) allow the DSPLL to perform hitless switching between input clocks (INx) that are fractionally related. Input switching is controlled manually or automatically using an internal state machine. The oscillator circuit (OSC) provides a frequency reference which determines output frequency stability and accuracy while the device is in free-run or holdover mode. The high-performance MultiSynth dividers (N) generate integer or fractionally related output frequencies for the output stage. A crosspoint switch connects any of the MultiSynth generated frequencies to any of the outputs. Additional integer division (R) determines the final output frequency.



Figure 16. SKY63104/05/06 Typical 56G/112G SerDes Application (Up to Three Domains)

# 5.1. Frequency Configuration

The frequency configuration of the DSPLL(s) is programmable through the serial interface and can also be stored in non-volatile memory. The combination of input dividers (P), fractional frequency multiplication (M), integer output division (Q), fractional output division (N), and integer output division (R) allows the generation of virtually any output frequency on any of the outputs. All divider values for a specific frequency plan are easily determined using the CBPro utility.

# 5.2. DSPLL Loop Bandwidth Initial Lock and Fast Lock Settings

The DSPLL loop bandwidth determines the amount of input clock jitter attenuation. Each DSPLL has a configurable loop bandwidth. The DSPLL will always remain stable with low peaking regardless of the loop bandwidth selection.

Each of the DSPLLs, have configurable loop bandwidths. There are three configurations, and each has a separate setting for the loop bandwidth:

- Initial Lock Bandwidth—The PLL uses this bandwidth when it exits the free-run mode and attempts to lock to a new input clock.
- Loop Bandwidth—This sets the bandwidth of the PLL once lock to an input is achieved.
- **Fastlock Bandwidth**—This sets the bandwidth of the PLL when exiting from holdover.

Selecting a low DSPLL loop bandwidth will generally lengthen the lock acquisition time. The fastlock feature allows setting a temporary Fastlock Loop Bandwidth that is used during the lock acquisition process. The DSPLL will revert to its normal loop bandwidth once lock acquisition has completed.

See the "Fifth Generation DSPLL<sup>®</sup> Wireline Jitter Attenuator Reference Manual" and CBPro for more information, recommendations, and limits for setting PLL loop bandwidths for different configurations.

# 5.3. Inputs

There are four differential inputs that can also be configured as single-ended CMOS inputs. Both INO and IN1 can support a single CMOS input, while IN2 and IN3 can be configured as dual CMOS inputs. This allows support for up to six CMOS inputs, or any combination of differential and CMOS inputs.



Figure 17. Input Structure

# 5.3.1. Input Terminations

Refer to the "Fifth Generation DSPLL<sup>®</sup> Wireline Jitter Attenuator Reference Manual" for guidance on input terminations.

### 5.3.2. Input Selection

Input selection for any of the PLLs can be controlled manually through pin control, API command, or automatically using an internal state machine.

### 5.3.2.1. Input Divider

The device utilizes multiple classes of both fractional and integer frequency dividers. The CBPro software will choose the optimal divide values based on the user-defined frequency plan. Refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for guidance on input dividers.

# 5.3.2.2. Manual Input Selection

In Manual mode, the input selection is made by defining a GPIO pin as an input select pin and changing the input pin voltage level, or by writing an API command. Any of the inputs are available to any of the PLLs through a crosspoint input selection switch. If there is no clock signal on the selected input, or if the input is not valid due to LOS/OOF/PHMON input alarms, the PLL will automatically enter Free-Run/Holdover mode. This applies to all the DSPLLs.

### 5.3.2.3. Phase Readout PHRD

The Phase Readout Device API can be used to read and measure the phase between multiple input clocks to the SKY63104/05/06. Unused inputs that are not assigned to a DSPLL can also be configured as phase readout (PHRD) or phase readout feedback (PHRD\_FB) inputs. These inputs can be used to measure the phase of an output of the SKY63104/05/06 to the input(s) of known phase. PHRD and PHRD\_FB inputs use the same alarms (LOS/OOF/PHMON) as the other clock inputs, but they are not assigned to a DSPLL.

### 5.3.2.4. Automatic Input Selection

When configured in this mode, each of the PLLs automatically selects a valid input that has the highest configured priority. The priority scheme is independently configurable for each PLL and supports revertive or non-revertive selection. All inputs are continuously monitored for loss of signal (LOS), invalid frequency range (OOF), and phase (PHMON). Only valid inputs that have no LOS, OOF or phase monitor (PHMON) alarms can be selected for synchronization by the automatic state machine. The PLL(s) will enter Free-Run or Holdover mode if there are no valid inputs available.

# 5.3.3. Unused Inputs

Unused inputs should be configured as "Unused (Powered Down)", and the pins may be left unconnected or accoupled to ground. Refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for recommendations on how to minimize system noise on any CMOS input or any differential input configured as "Enabled" but not actively being driven by a clock.

# 5.3.4. Synchronizing to Gapped Input Clocks

The DSPLL supports locking to an input clock that has missing periods. This is also referred to as a gapped clock. The purpose of gapped clocking is to modulate the frequency of a periodic clock by selectively removing some of its cycles. Gapping a clock severely increases its jitter so a phase-locked loop with high jitter tolerance and low loop bandwidth is required to produce a low-jitter periodic clock. The resulting output will be a periodic non-gapped clock with an average frequency of the input with its missing cycles. For example, an input clock of 100 MHz with one cycle removed every 10 cycles will result in a 90 MHz periodic non-gapped output clock, as shown in Figure 8. For more information on gapped clocks, see "AN561: Introduction to Gapped Clocks and PLLs".



### Figure 18. Generating an Averaged Clock Output Frequency from a Gapped Clock Input

A valid gapped clock input must have a minimum frequency of 10 MHz with a maximum of two missing cycles out of every eight. Locking to a gapped clock will not trigger the LOS, OOF, and LOL fault monitors. Clock switching between gapped clocks may violate the hitless switching specification when the switch occurs during a gap in either input clock.

# 5.4. Input Clock Switching

Clock inputs to the SKY63104/05/06 can be either from the same source (0 ppm, same nominal frequency) or different sources (non-0ppm different nominal frequency). The SKY63104/05/06 automatically determines the optimal switching mode depending on the nominal frequency difference between the clocks at the time of the switch.

When switching between 0 ppm inputs, the SKY63104/05/06 performs either a hitless switch with phase buildout (PBO) or a phase pull-in (PPI) switch, depending on the setting in CBPro. When switching between non-0 ppm offset, the SKY63104/05/06 performs a frequency-ramped Input switch with user-programmable frequency ramp rate. Refer to the

"Fifth Generation DSPLL<sup>®</sup> Wireline Jitter Attenuator Reference Manual" for additional guidance on input clock switching modes. All input clock switches are glitchless meaning there will be no runt pulses generated at the output during the transition.

# 5.4.1. Hitless Input Switching for 0 ppm clocks Phase Buildout PBO

SyncE applications require that transients are kept to a minimum when switching between inputs. Hitless switching with phase buildout (PBO) is a feature that prevents a phase offset from propagating to the output when switching between two clock inputs that have a fixed phase relationship. A hitless switch can only occur when the two input frequencies are frequency locked, meaning that the nominal frequencies are the same (0 ppm). Due to the nature of hitless switching, the input-to-output delay of the PLL is not preserved. The DSPLL simply absorbs the phase difference between the two input clocks during an input switch. The phase buildout feature supports clock frequencies down to a minimum input frequency of 8 kHz.

### 5.4.2. Phase Pull-In (PPI) Input Switching for 0 ppm clocks

In some applications, the output phase must track the input phase with minimal delay. When the application requires the input-to-output delay to be preserved after clock switching, the phase pull-in clock switching mode should be selected. In this mode, the output phase will be pulled in at a user-programmable ramp rate referred to

as the PPI slope (ns/s). With phase pull-in switching, the output phase always aligns with the newly selected input. PPI is always enabled for zero-delay mode applications.

# 5.4.3. Ramped Input Switching for non-0 ppm clocks

The ramped switching feature allows the DSPLLs to switch between two input clock frequencies that are non-0 ppm without an abrupt frequency transient at the output. When the two input clock frequencies are not the same nominal frequency, the DSPLL will pull in the frequency difference between inputs at the ramp rate that is programmable in CBPro from ppb/s to ppm/s. The Loss-of-Lock (LOL) and LOOP\_FILTER\_RAMP\_IN\_PROGRESS indicators (accessible through the Device API) will assert while the DSPLL is ramping to the new clock frequency.

# 5.5. Outputs

The SKY63104/05/06 supports 12 differential output drivers with configurable voltage swing and common mode voltage covering a wide variety of differential signal formats. In addition to preset differential levels such as LVPECL, LVDS, S-LVDS, CML and HCSL, the SKY63104/05/06 can also be programmed to a custom differential threshold that allows the signal to be sent directly to chipsets from vendors like Broadcom without complicated termination circuits simplifying the complexity of the board layout.

The outputs can also be configured as single-ended LVCMOS (3.3 V, 2.5 V, or 1.8 V) providing up to 24 single-ended outputs, or any combination of differential and single-ended outputs. The outputs have power supply pins (VDDOx) for output driver groups of 3-2-4-3, which can be powered at 3.3 V, 2.5 V, or 1.8 V. The LVCMOS output voltage is set by the VDDOx pin. Refer to "2. Pin Descriptions" on page 5.

# 5.5.1. Output Crosspoint

A crosspoint allows any of the output drivers to connect with any of the PLLs. A digital output delay adjustment is possible on each of the Q divider outputs to provide output-to-output alignment for the same output source. The crosspoint configuration and delay adjustments are programmable and are stored in NVM so that the desired output configuration is ready at power-up.



Figure 19. Output Structure

# 5.5.2. Differential and LVCMOS Output Terminations

Refer to the "Fifth Generation DSPLL<sup>®</sup> Wireline Jitter Attenuator Reference Manual" for guidance on output terminations.

# 5.5.3. Output Enable/Disable

Each output driver may be enabled/disabled through programmable GPIO pins. There are two output enable groups, OEO and OE1, which are logically ORed together to determine which outputs are enabled at any point in time. CBPro allows the control and selection of the GPIO pin mapping to the outputs.

Outputs may also be enabled/disabled using the device API. For more details on controlling the output enable/disable, refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual".

# 5.5.4. State of Disabled Output

The disabled state of an output driver may be configured as stop high, stop low, or Hi-Z. CMOS outputs <2 MHz can also be configured as Hi-Z with weak internal pullup/down.

Differential outputs, when disabled, will maintain the output common-mode voltage even while the output is not toggling. This minimizes disturbances when disabling and enabling clock outputs.

# 5.5.5. Output Dividers

The device utilizes both integer Q dividers and fractional NA, NB MultiSynth output dividers. The ClockBuilder Pro software chooses the optimal divide values based on the user-defined frequency plan.

A summary of each class of divider is listed below:

- 1. Output Q divider: Q11-Q0 -Integer Only Divide Value -Open loop divider taps directly off VCO
- 2. DSPLLA/B feedback M divider: MA, MB -Integer or Fractional Divide Value
- 3. Output N divider: NA, NB -MultiSynth Divider, Integer or Fractional Divide Value
- 4. Output divider: R11-R0 -Integer-only divide value
- 5. Synchronized dual outputs
  - -If one N divider is used in a closed loop fashion and the other N divider is used in an open loop fashion, the dividers may be cascaded so that the output of each N-divider is derived from the same input clock source and is capable of having a fractional frequency relationship.

# 5.5.6. Output Skew Control

Output skew control allows outputs that are derived from the Q dividers to be phase adjusted in steps of 1/fvco or  $1/(4 \times fvco)$  when the fine adjust is enabled. The exact skew adjustment and step sizes are reported on the Output Skew Control Tab of the CBPro Wizard.

# 5.6. DSPLLP with Output Q-Divider (High Performance Path)

DSPLLP is the high-performance PLL and is routed through the Integer Q-divider to deliver the best jitter performance. DSPLLP controls the central VCO which provides many of the essential functions for the device such as generating ultra-low phase noise clocks and maintaining free-run accuracy and holdover stability for all PLLs (DSPLLP, DSPLLA, DSPLLB). A simple low-cost fixed frequency crystal (XTAL) provides the phase noise reference, and the DSPLLP locks to a clock input for jitter attenuation. The option of using a crystal oscillator (XO) is also available. See the "Fifth Generation DSPLL<sup>®</sup> Wireline Jitter Attenuator Reference Manual" for more information on the configuration modes and CBPro for configuring the modes.

# 5.7. DSPLLA and DSPLLB with Output Divider NA/NB

In general, both DSPLLA and DSPLLB have identical performance and flexibility and can be independently configured and controlled through the serial interface. Each of the DSPLLs support locked, free-run, and holdover modes of operation. These DSPLLs share the stability from the reference applied to DSPLLP in order to support free-run and holdover modes.

DSPLLA and DSPLLB cannot be routed via the Integer Q divider and instead use N and R dividers to deliver multiple system clocks.

The SKY63104 has one DSPLL (DSPLLP) and two fractional MultiSynth N dividers (NA/NB).

The SKY63105 has two DSPLLs (DSPLLP and DSPLLA) and one fractional MultiSynth N divider (NB).

The NB divider can be connected to either DSPLLP or DSPLLA before being fed to the output R dividers.

The SKY63106 has three DSPLLs (DSPLLP, DSPLLA, and DSPLLB) that are fed directly to the output R dividers.

### 5.7.1. DCO Mode

The DCOs in each of the DSPLLs can be frequency controlled in predefined steps ranging from <1 ppt to several ppm. The DCOs can be controlled when its DSPLL is locked to an external input or when it is in Free-Run/Holdover mode. The frequency adjustments are controlled through the serial interface by triggering a Device API command, or by pin control using frequency increments (FINC) or decrements (FDEC). Both the FINC and FDEC pins are available through the configurable GPIO pins. Each DSPLL can be assigned to the FINC and FDEC pins. An FINC will add the frequency step word to the DSPLL output frequency, while an FDEC will decrement it.

# 5.8. Zero Delay Mode (ZDM)

Zero Delay Mode (ZDM) is a mode of PLL operation in which more accurate input-to-output phase delay can be achieved by providing an external feedback from one of the clock outputs to one of the clock inputs. ZDM is available on each of the three PLLs (DSPLLP, DSPLLA, and DSPLLB). See the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for more details on implementing ZDM.
# 5.9. External Reference

An external crystal (XTAL) or crystal oscillator (XO) is used in combination with the internal oscillator (OSC) to produce an ultra-low jitter reference clock for the DSPLL and for providing a stable reference for the free-run and holdover modes. When using an external XO, it's important to select one that meets the jitter performance requirements of the end application. See the "Recommended XTAL, XO, VCXO, TCXO, and OCXO Reference Manual" for more details.

### 5.9.1. XA/XB Inputs

An external crystal (XTAL) connected to the XA/XB pins provides a fixed frequency reference for the PLLs (DSPLLP, DSPLLA, DSPLLB). The device includes internal XTAL loading capacitors which eliminate the need for external capacitors and also has the benefit of reduced noise coupling from external sources. A crystal in the range of 48 to 54 MHz is recommended for best jitter performance.

## 5.9.2. XO\_IN Input

An alternative to using an external XTAL is to connect a single-ended CMOS crystal oscillator (XO) directly to the XO\_IN Input. Note that XO phase noise at frequencies between the DSPLLP outer loop bandwidth of approximately 20 Hz to 40 kHz and the inner loop bandwidth of approximately 1 MHz will pass through to the output. In addition to selecting XOs with appropriate noise in this frequency band, be sure to filter the VDD supplying power to the XO as many XOs have poor supply rejection.

# 5.10. GPIO (General Purpose Input/Output)/Four-Wire SPI Interface

SKY63104/05/06 variants with internal NVM have four GPIO pins that are programmable to be input or output via ClockBuilder Pro (See Table 17 below).

Function	Description		
GPIO Selectable Control Inputs (GPI)			
FINC	DCO Frequency Increment.		
FDEC	DCO Frequency Decrement.		
PLLx_FORCE_HO	Force holdover for DSPLLP, or DSPLL A, or DSPLL B.		
PLLx_INSEL[0-2]	Input select pins for DSPLLP, or DSPLL A, or DSPLL B. There are three bits to select from one of six inputs.		
IN[0:5]_FAIL	Force input invalid. A low on this pin indicates to the automatic switching state machine that the associated input is not valid for selection. This is useful in applications that use their own input monitoring.		
OE0–OE1	Output enable for specific outputs or group of outputs as defined by the grouping assigned in CBPro.		

#### Table 17. GPIO Functions for Internal NVM

Function	Description
GPIO Selectable Status O	Dutputs (GPO)
PLLx_LOL	Loss of lock for DSPLLP, DSPLLA, DSPLLB.
INx_LOS	Loss Of Signal status indicator for INx.
XO_OOF	Out Of Frequency status indicator of the reference.
INx_OOF	Out Of Frequency status indicator for INx.
XO_LOS	Loss of signal at XA/XB or XO_IN pins.
PLLx_HO	This pin indicates when DSPLLP, DSPLLA, DSPLLB has entered the holdover state.
INTR	Interrupt pin for the device. Programmable Boolean combination of PLLx_LOL, INx_LOS, INx_OOF, PLLx_HO, XO_LOS, XO_OOF.

#### Table 17. GPIO Functions for Internal NVM (Continued)

For SKY63104/05/06 variants with external flash, these four pins are programmed as the four-wire SPI interface for the external flash. GPIO functions on these four pins are not available and will be preassigned as shown in Table 18 below.

#### Table 18. GPIO Functions for External Flash

Pin	Name	SPI for Flash Control
15	GPIO0	FSDI-Data in from Flash
16	GPIO1	FSDO-Data out to Flash
17	GPIO2	FSCLK-Clock output to Flash
39	GPIO3	FCSB-Chip Select

OUT2/11 can also be repurposed as GPIOs, for both the internal NVM and external flash variants, when they are not being used as clock outputs.

Additional details are available in the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual".

# 5.11. Device Initialization and Reset

Once power is applied and RSTb is deasserted, the device begins loading preconfigured register values and configuration data from NVM, and performs other initialization tasks. Communicating with the device through the serial interface is possible once this initialization period is complete (see  $t_{RDY}$ ). No output clocks will be generated until the initialization is complete, and the device locks to the external (VC)XO/XTAL (see  $t_{START_XO}$  and  $t_{START_XTAL}$ ). A reset, initiated using the RSTb pin or through the Device API RESTART command, restores all registers to the values stored in NVM, and all circuits, including the serial interface, will be restored to their initial state. All clocks will stop during a hard reset. Other feature-specific resets are also available. See the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" and "AN1360: Serial Communications and API Programming Guide for Si536x, Si540x, and Si55xx Devices" for more information on different methods of resetting the device.



Figure 20. Modes of Operation

# 5.12. Modes of Operation: DSPLLP, DSPLLA, and DSPLLB

Once initialization is complete each PLL independently operates in one of four modes: Free-Run, Lock Acquisition, Locked, or Holdover. A state diagram showing the modes of operation is shown in Figure 20 above. The following sections describe each of these modes in greater detail.

## 5.12.1. Free-Run Mode

The PLLs will automatically enter Free-Run mode once power is applied to the device and initialization is complete. In this mode, the frequency accuracy of the generated output clocks is entirely dependent on the frequency accuracy of the reference clock source. If an XTAL is connected to the XA/XB pins, then the clock outputs will generate a frequency at the XTAL's accuracy. For example, if an XTAL is operating at –28 ppm, then clock outputs will also be –28 ppm. The same is true if an XO is connected at the XO\_IN inputs instead of using XTAL at XA/XB. The frequency stability of the outputs will also be determined by the XTAL or XO.

## 5.12.2. Lock Acquisition Mode

Each of the PLLs independently monitors its configured inputs for a valid clock. If at least one valid clock is available for synchronization, a PLL will automatically start the lock acquisition process. If the fast lock feature is enabled, they will acquire lock faster than the PLL Loop Bandwidth would provide and then transition to the normal PLL loop bandwidth. During lock acquisition the outputs will generate a clock that follows the VCO frequency change as it pulls-in to the input clock frequency.

The PLL\_STATUS API command reports the lock status of a PLL. When the PLL output frequency is within the threshold defined on the Frequency LOL (FLOL) page in ClockBuilder Pro, the PLL\_OUT\_OF\_FREQUENCY bit deasserts. Some time after that, the PLL will pull in the remaining phase defined on the Phase LOL (PLOL) page in ClockBuilder Pro. Once the PLL is frequency and phase locked, the PLL\_LOSS\_OF\_LOCK (LOL) bit deasserts and the PLL enters locked mode.

## 5.12.3. Locked Mode

Once locked, the PLL will generate clock outputs that are both frequency and phase locked to their selected input clocks. The PLL loop bandwidths can be independently configured. Any frequency changes (e.g., because of temperature variations) of the reference clock (XO\_IN) within the PLL loop bandwidth will be corrected by the loop ensuring 0 ppm lock to its input clock (IN). Any frequency changes of the reference clock (XO\_IN) beyond the PLL loop bandwidth will pass through to the clock output.

## 5.12.4. Holdover Mode

Any of the PLLs will automatically enter Holdover mode when the selected input clock becomes invalid, holdover history is valid, and no other valid input clocks are available for selection. Each PLL uses an averaged input clock frequency as its final holdover frequency to minimize the disturbance of the output clock phase and frequency when an input clock suddenly fails. The holdover circuit for each PLL stores historical frequency data while locked to a valid input clock. The final averaged holdover frequency value is calculated from a programmable window within the stored historical frequency data. Both the window size and delay are programmable as shown in the figure below. The window size determines the amount of holdover frequency averaging. The delay value allows ignoring frequency data that may be corrupt just before the input clock failure.

The maximum window size is a function of input frequency and is reported in CBPro for each PLL. Up to 5000 seconds of holdover history can be stored.



Figure 21. Programmable Holdover Window

When entering holdover, a PLL will pull its output clock frequency to the calculated averaged holdover frequency. While in holdover, the output frequency drift is entirely dependent on the external reference clock connected to the XO\_IN input. If the input clock becomes valid, a PLL will automatically exit the holdover mode and re-acquire lock to the new input clock. This process involves pulling the output clock frequency to achieve frequency and phase lock with the input clock. This pull-in process is glitchless.

The PLL output frequency when exiting holdover can be ramped. Just before the exit is initiated, the difference between the current holdover frequency and the new desired frequency is measured. Using the calculated difference and a user-selectable ramp rate, the output is linearly ramped to the new frequency. The PLL loop BW does not limit or affect ramp rate selections (and vice versa). CBPro defaults to ramped exit from holdover and free-run. The ramp rate settings are configurable for initial lock (exit from free-run), exit from holdover, and clock switching.

If ramped holdover exit is disabled, the holdover exit is governed either by (1) the PLL loop BW or (2) the PLL Fastlock bandwidth, when enabled.

# 5.13. Status and Alarms

The SKY63104/05/06 monitors the input clocks and reference input for status and alarms. These states and alarms provide the internal state machine with real time phase and frequency monitoring used for making decisions, such as switching inputs or entering holdover.

# 5.13.1. Input Clock Status

All input clocks are continuously monitored for faults using the Loss-of-Signal (LOS), Out-of-Frequency (OOF), and Phase Monitor (PHMON) alarms. When a differential input is configured as a dual CMOS input, then each CMOS input is independently monitored. Any enabled alarms for an input, such as LOS/OOF/PHMON, are logically ORed together to produce the "Input Invalid" alarm.

Any input clock with an alarm is not valid until all alarms are cleared. If a PLL is locked to an input clock and that input clock becomes invalid, then the PLL may either switch to a valid input or enter holdover mode, depending on how the device is programmed.

API commands can be used to indicate if an alarm is valid, pending short term fault, under validation or invalid.

### 5.13.1.1. Loss of Signal LOS

The loss of signal alarm measures the period of each input clock cycle to detect phase irregularities or missing clock edges. Each of the input LOS circuits has its own programmable sensitivity, which allows missing edges or intermittent errors to be ignored. Loss of signal sensitivity is configurable using the CBPro utility. The LOS status for each of the monitors is accessible by checking the INPUT\_STATUS API.

#### 5.13.1.2. Out of Frequency (OOF) Detection

All inputs are monitored for frequency accuracy with respect to an OOF reference which is selected in ClockBuilder Pro. The OOF reference can be selected as the XO/XTAL.

The OOF set and clear thresholds must be wider than the combined frequency accuracy of the OOF reference plus the stability of the input clock. A valid input clock frequency is one that remains within the OOF frequency range which is configurable from  $\pm 0.1$  ppm to  $\pm 500$  ppm in steps of 0.1 ppm. A configurable amount of hysteresis is also available to prevent the OOF status from toggling at the failure boundary.

An example is shown in the figure below. In this case, the OOF monitor is configured with a valid frequency range of ±15 ppm with 5 ppm of hysteresis.





#### 5.13.1.3. Phase Monitor (PHMON)

If a clock input undergoes a phase transient, a PLL locked to that input will filter the transient by its loop bandwidth; however, the transient will propagate to the output. Transients that propagate to the output have the potential to negatively impact downstream devices.

Phase Monitor (PHMON) alarm monitors the input clock phase or accumulated phase, and, if the input transient exceeds the programmable threshold, the PHMON alarm will be asserted. PHMON, like the other alarms, is quick to be asserted when the thresholds are violated yet slower to be deasserted to prevent chattering around the threshold.

Each input clock has an independent PHMON alarm. Each alarm can be enabled/disabled individually, and its associated threshold may be independently configured. Note that OOF must be enabled and properly configured for PHMON to operate.

A ZDM input may use the PHMON alarm for monitoring purposes. However, it will have no effect on PLL bandwidth selection and will not cause input switching.

#### 5.13.1.4. Short Term Holdover

The Short-Term Holdover (STHO) feature may be used when the input clock is expected to have a short-term fault and then quickly recover.

If an input clock has STHO enabled, and an LOS/OOF/PHMON alarm is asserted, then a PLL locked to that input will enter holdover and wait for a programmable duration until all alarms on the input clock are deasserted.

If all alarms on the input clock are deasserted before the programmable amount of time has passed, then the PLL will gracefully relock to the same input clock. If all the alarms on the input clock are not deasserted before the programmable amount of time has passed, then the PLL will either switch to the next priority input clock or remain in holdover, depending on the input clock selection settings.

If STHO is disabled, then the PLL will skip the short-term holdover time and immediately switch to the next priority input clock or enter holdover, depending on the input clock selection settings.

STHO may be programmed using Clock Builder Pro to set the duration or to enable or disable the feature for each input clock individually. Note that the STHO setting will affect all PLLs assigned to that input.

#### 5.13.2. PLL Status

DSPLLP, DSPLLA, and DSPLLB are continuously monitored for Loss-of-Lock (LOL). The final LOL status indicator is the logical OR of the Frequency Loss-of-Lock and Phase Loss-of-Lock statuses. See the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for more information.

#### 5.13.2.1. Loss of Lock (LOL)

There is a loss of lock (LOL) monitor for each of the PLLs (DSPLLP, DSPLLA, and DSPLLB). The LOL monitor asserts when a PLL has lost synchronization with its selected input clock. Any of the GPIOs can be programmed as a dedicated loss-of-lock pin that reflects the loss-of-lock condition for each of the PLLs. The LOL monitor measures both the frequency and phase difference between the input and feedback clocks of the phase detector. The frequency monitor gives frequency lock detection (FLOL) while the phase monitor indicates true phase lock PLOL by detecting one or more single slips. Both the phase and frequency LOL monitors have clear and set thresholds and a timer to prevent LOL assertion from toggling or chattering as the DSPLL completes lock acquisition. The cycle slip detector also has configurable sensitivity.

#### 5.13.2.2. Frequency Loss of Lock (FLOL)

The Frequency Loss-of-Lock (FLOL) monitor measures the frequency difference between the input clock and the feedback clock. The upper and lower LOL thresholds are programmable, which dictates when the alarm will be asserted or deasserted. It is recommended to program the clear threshold to be less than the set threshold to allow for hysteresis in the FLOL set/clear behavior. This prevents the FLOL alarm from chattering or causing multiple interrupts. FLOL, like the other alarms, is quick to be asserted when the threshold is violated yet slower to be deasserted. The alarm validates that the frequency difference between the input and feedback clocks has truly settled to within the LOL clear threshold before the FLOL alarm is deasserted. The time required to validate the frequency difference increases as the loop bandwidth of the PLL decreases.

#### 5.13.2.3. Status Bits

There are four Status Bits that serve as four additional Frequency LOL thresholds. The Status Bit is asserted if the frequency difference between the input clock and feedback clock exceeds the programmable STB threshold. The assertion or deassertion of an STB does not contribute to the FLOL or LOL status. Rather, they serve as a way to track the lock acquisition process for DSPLL's with a loop bandwidth of ~20 Hz. The status bits may be read via the API. In the lock acquisition process, the deassertion of a STB does not indicate that the PLL is frequency locked. This is because the frequency may chatter around the STB threshold. On the other hand, the deassertion of FLOL requires the frequency difference to truly settle below the LOL clear threshold.

#### 5.13.2.4. Phase Loss of Lock (PLOL)

The Phase Loss-of-Lock (PLOL) alarm measures the phase difference between the input clock and feedback clock. The PLOL set threshold is programmable so the alarm will assert or deassert depending on phase difference between the input and feedback clocks relative to the threshold setting. It is recommended to set the clear threshold below the set threshold to allow for hysteresis. This prevents the alarm from chattering or causing multiple interrupts. During the lock acquisition process the input clock and feedback clock will likely have a significant frequency mismatch so the PLOL is asserted until FLOL is deasserted. Once FLOL has been deasserted, the two frequencies are stable with respect to each other. Then the feedback clock phase can be pulled in to within the PLOL clear threshold.

#### 5.13.2.5. Cycle Slip Detection

DSPLLP, DSPLLA, and DSPLLB may be monitored for cycle slips. Like the PLOL alarm, cycle slip detection is not enabled until FLOL is deasserted. Additionally, PLOL must be enabled for cycle slip detection to be enabled. Cycle slips both in the positive and negative direction are monitored. The API can be used to read the total count of positive cycle slips, negative cycle slips and the total count or both positive and negative slips.

## 5.13.3. External Reference Status

An external reference must always be provided to the device. The SKY63104/05/06 will monitor the external reference input for LOS, OOF, LOL. If a fault is detected on the external reference, then the outputs will be disabled.

Any external reference faults may be read via the API.

#### 5.13.4. Interrupt Status

The interrupt flag is asserted when any of the status indicators of the device changes state. The interrupt status may be assigned a GPIO pin, or it may be checked using an API command to show which status indicator caused the interrupt to be asserted.

The Interrupt Pin page in CBPro lists all the status indicators that can be programmed to activate the interrupt pin.

The status indicators that are enabled are logically OR'd together so that the assertion of any of these status indicators will cause the interrupt pin to assert. The interrupt pin status depends on the sticky versions of the individual status indicators, so the interrupt pin will stay asserted until the sticky status indicators are cleared.

# 5.14. Serial Interface

Configuration and operation of the SKY63104/05/06 is controlled by reading and writing API commands using the I<sup>2</sup>C or SPI interface. The SPI mode operates in either 4-wire or 3-wire modes. The following table defines the GPIO pins assigned to the SPI port. For more information, see "AN1360: Serial Communications and API Programming Guide for Si536x, Si540x, and Si55xx Devices".

Pin Number	3-Wire SPI	4-Wire SPI	I <sup>2</sup> C
41	CSb	CSb	AO
37	SDIO	SDI	SDA
38	SCLK	SCLK	SCK
42	Unused	SDO	A1

#### **Table 19. Serial Interface Pins**

## 5.15. NVM Programming and External Flash Support

At power-up, the device downloads its default configuration and settings either from an internal non-volatile memory (NVM) or from external flash. This option is settable during device configuration in CBPro.

If the NVM option is selected, the internal NVM can be preprogrammed at the factory with a custom frequency plan such that the device starts generating clocks on its first power-up. The NVM can also be programmed in the field using the API command set. NVM programming must be done with VDDA set to 3.3 V.

If the Flash option is selected, the device starts with the frequency plan stored externally. This option is useful for customers who want the flexibility to modify the boot-up configuration in the field. For more details on NVM or Flash programming, refer to "AN1360: Serial Communications and API Programming Guide for Si536x, Si540x, and Si55xx Devices" and the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual".

# 5.16. Application Programming Interface API

Communication between the customer's host processor and the SKY63104/05/06 internal microcontroller (MCU) is accomplished through the serial interface. The SKY63104/05/06 MCU contains API firmware that allows users simple command level access to the device's registers. For more details on the Device API and for instructions on programming the clock device, see "AN1360: Serial Communications and API Programming Guide for Si536x, Si540x, and Si55xx Devices" and the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual".

# 5.17. Power Supplies

The SKY63104/05/06 has 11 power supply pins. The separate power supplies are used for different functions, providing power locally where it is needed on the die to improve isolation. When no outputs are enabled for a particular VDDOx, that supply pin may be left unconnected. Please refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for more details on power management and filtering recommendations.

## 5.17.1. Power Supply Sequencing

There are no power sequencing requirements between supplies. VDDA and VDD18 should be powered up before releasing RSTb. VDDA must be equal to the highest voltage supply.

#### 5.17.2. Power Supply Ramp Rate

Power supply ramp times must stay within the maximum supply voltage ramp rate as defined in Table 8, "DC Characteristics," on page 15.

#### 5.17.3. Low-Power Mode

In Low-Power Mode, the analog core supply voltage (VDDA) of the SKY63104/05/06 is set to 1.8 V in order to reduce power consumption. Since VDDA must be equal to the highest voltage applied to the SKY63104/05/06, in Low-Power Mode, all voltage supplies including VDDO must be 1.8 V. A 1.8 V VDDO restricts the output format to S-LVDS, LVCMOS, or HCSL. If standard LVPECL / LVDS common-mode voltages are required in Low-Power Mode, select ac-coupled HCSL / S-LVDS output formats, respectively, with corresponding common-mode bias on the receiver side of the ac coupling capacitors. NVM programming in the field is not supported in Low-Power Mode since NVM programming requires VDDA to be 3.3 V. Please refer to the "Fifth Generation DSPLL® Wireline Jitter Attenuator Reference Manual" for VDDXO and XO/XTAL connections and terminations for Low-Power Mode.

# 6. Package Outline



Figure 23. 56-QFN 8x8 mm Package Diagram

# 7. PCB Land Pattern



Figure 24. 56-QFN 8x8 mm PCB Land Pattern

#### Table 20. 56-QFN 8x8 mm PCB Land Pattern Dimensions

Dimension	mm	Notes			
C1	7.75	General 1. These notes and stencil design are shared as recommendations only.			
C2	7.75	A customer or user may find it necessary to use different parameters and fine tune their SMT process as required for their application and tooling.			
E	0.5	<ol> <li>All dimensions shown are in millimeters (mm).</li> <li>This Land Pattern Design is based on the IPC-7351 guidelines.</li> <li>All dimensions shown are at Maximum Material Condition (MMC).</li> </ol>			
L	0.55	Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm. Solder Mask Design			
W	0.25	<ol> <li>All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal is to be 60 μm minimum, all the way around the pad.</li> </ol>			
X1	6.7	Stencil Design 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder			
X2	6.7	<ul> <li>paste release.</li> <li>2. The stencil thickness should be 0.125 mm (5 mils).</li> <li>3. The ratio of stencil aperture to land pad size should be 1:1 for all pads.</li> <li>4. A 4x4 array of 1.45 mm square openings on a 2.00 mm pitch should be used for the center ground pad.</li> <li>Card Assembly</li> <li>1. A No-Clean, Type-3 solder paste is recommended.</li> <li>2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.</li> </ul>			

# 8. Top Marking



Figure 25. SKY63104/05/06 Top Marking

Line	Characters	Description		
	Circle with 0.6 mm diameter	Pin 1 indicator; left-justified.		
1		Base part number and Device Grade:		
	SKY6310xG	G = Device Grade. See "9. Ordering Guide" on page 50 for latest device grade information.		
2	RxxxxGM	R = Product revision. See "9. Ordering Guide" on page 50 for latest revision. xxxxx = Customer-specific sequence number. Optional boot-configuration code assigned for custom, factory programmed devices. Characters are not included for standard, factory default configured devices. See "9. Ordering Guide" on page 50 for more information. GM = Package (QFN) and temperature range (-40 to +95 °C).		
3	ттттттт	TTTTTTTT = Manufacturing trace code.		
4	YYWW	YYWW = Year (YY) and Week (WW) of package assembly.		
4	TW	TW = Taiwan; Country of Origin (ISO Abbreviation).		

# 9. Ordering Guide

Ordering Part Number (OPN) <sup>1</sup>	Number of DSPLLs	Number of MultiSynths	Internal NVM/ External Flash	Interface	Package
SKY63104A-A-GF/R	1	2	Internal NVM	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104AAxxxxxGF/R	1	2	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104BAxxxxxGF/R	1	1	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104CAxxxxxGF/R	1	0	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104D-A-GF/R	1	2	External Flash	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104DAxxxxxGF/R	1	2	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104EAxxxxxGF/R	1	1	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104FAxxxxxGF/R	1	0	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63104AA-EVB <sup>2</sup>	1	2	Internal NVM (External Flash)	SPI 4-wire	SKY63104 evaluation board

#### Table 22. SKY63104 Ordering Part Numbers

1. The blank parts, SKY63104A-A-GF and SKY63104D-A-GF, are preconfigured to be a 4-wire interface. For Factory programmed plans and blank parts requiring other interface standards like I<sup>2</sup>C and 3-wire, custom part numbers (Axxxxx) are created using CBPro.

2. The SKY63104AA-EVB is supported by the Pluto evaluation platform. See the Pluto evaluation platform user guide for more information.

Ordering Part Number (OPN) <sup>1</sup>	Number of DSPLLs	Number of MultiSynths	Internal NVM/ External Flash	Interface	Package
SKY63105A-A-GF/R	2	1	Internal NVM	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105AAxxxxxGF/R	2	1	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105BAxxxxxGF/R	2	0	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105D-A-GF/R	2	1	External Flash	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105DAxxxxxGF/R	2	1	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105EAxxxxxGF/R	2	0	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63105AA-EVB <sup>2</sup>	2	1	Internal NVM (External Flash)	SPI 4-wire	SKY63105 evaluation board

#### Table 23. SKY63105 Ordering Part Numbers

1. The blank parts, SKY63105A-A-GF and SKY63105D-A-GF, are preconfigured to be a 4-wire interface. For Factory programmed plans and blank parts requiring other interface standards like I<sup>2</sup>C and 3-wire, custom part numbers (Axxxxx) are created using CBPro.

2. The SKY63105AA-EVB is supported by the Pluto evaluation platform. See the Pluto evaluation platform user guide for more information.

Ordering Part Number (OPN) <sup>1</sup>	Number of DSPLLs	Number of MultiSynths	Internal NVM/ External Flash	Interface	Package
SKY63106A-A-GF/R	3	0	Internal NVM	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63106AAxxxxxGF/R	3	0	Internal NVM	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63106D-A-GF/R	3	0	External Flash	SPI 4-wire	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63106DAxxxxxGF/R	3	0	External Flash	SPI 4-wire or 3-wire or I <sup>2</sup> C	56-lead Wettable-Flank QFN 8 x 8 mm
SKY63106AA-EVB <sup>2</sup>	3	0	Internal NVM (External Flash)	SPI 4-wire	SKY63106 evaluation board

#### Table 24. SKY63106 Ordering Part Numbers

1. The blank parts, SKY63106A-A-GF and SKY63106D-A-GF, are preconfigured to be a 4-wire interface. For Factory programmed plans and blank parts requiring other interface

standards like I<sup>2</sup>C and 3-wire, custom part numbers (Axxxxx) are created using CBPro.

2. The SKY63106AA-EVB is supported by the Pluto evaluation platform. See the Pluto evaluation platform user guide for more information.



\* 5-digits, assigned by ClockBuilder Pro for custom OPN devices.

Figure 26. Ordering Guide

# **10.** Revision History

Revision	Date	Description
А	May, 2025	Initial release.

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